

## MAXIMUM RATINGS

Rating	Symbol	MPQ7091	MPQ7092	MPQ7093	Unit
Collector-Emitter Voltage	V <sub>CEO</sub>	150	200	250	Vdc
Collector-Base Voltage	V <sub>CBO</sub>	150	200	250	Vdc
Emitter-Base Voltage	V <sub>EBO</sub>		5.0		Vdc
Collector Current — Continuous	I <sub>C</sub>		500		mAdc
		Each Die	Four Die Equal Power		
Total Device Dissipation @ T <sub>A</sub> = 25°C Derate above 25°C	P <sub>D</sub>	750 5.98	1700 13.6		mW mW/°C
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	1.25 10	3.2 25.6		Watts mW/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to +150			°C

## THERMAL CHARACTERISTICS

Characteristic	Junction to Case	Junction to Ambient	Unit
Thermal Resistance Each Die Effective, 4 Die	100 39	167 73.5	°C/W °C/W
Coupling Factors Q1-Q4 or Q2-Q3 Q1-Q2 or Q3-Q4	46 5.0	56 10	% %

## ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>					
Collector-Emitter Breakdown Voltage (I <sub>C</sub> = 1.0 mAdc, I <sub>B</sub> = 0)	V <sub>(BR)CEO</sub> MPQ7091 MPQ7092 MPQ7093	150 200 250	— — —	— — —	Vdc
Collector-Base Breakdown Voltage (I <sub>C</sub> = 100 μAdc, I <sub>E</sub> = 0)	V <sub>(BR)CBO</sub> MPQ7091 MPQ7092 MPQ7093	150 200 250	— — —	— — —	Vdc
Emitter-Base Breakdown Voltage (I <sub>E</sub> = 100 μAdc, I <sub>C</sub> = 0)	V <sub>(BR)EBO</sub>	5.0	—	—	Vdc
Collector Cutoff Current (V <sub>CB</sub> = 120 Vdc, I <sub>E</sub> = 0) (V <sub>CB</sub> = 150 Vdc, I <sub>E</sub> = 0) (V <sub>CB</sub> = 180 Vdc, I <sub>E</sub> = 0)	I <sub>CBO</sub> MPQ7091 MPQ7092 MPQ7093	— — —	— — —	250 250 250	nAdc
Emitter Cutoff Current (V <sub>BE</sub> = 3.0 Vdc, I <sub>C</sub> = 0)	I <sub>EBO</sub>	—	—	100	nAdc

## ON CHARACTERISTICS

DC Current Gain (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 10 Vdc) (I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 10 Vdc) (I <sub>C</sub> = 30 mAdc, V <sub>CE</sub> = 10 Vdc)	h <sub>FE</sub>	25 35 25	40 55 50	— — —	—
Collector-Emitter Saturation Voltage (I <sub>C</sub> = 20 mAdc, I <sub>B</sub> = 2.0 mAdc)	V <sub>CE(sat)</sub>	—	0.3	0.5	Vdc
Base-Emitter Saturation Voltage (I <sub>C</sub> = 20 mAdc, I <sub>B</sub> = 2.0 mAdc)	V <sub>BE(sat)</sub>	—	0.7	0.9	Vdc

## SMALL-SIGNAL CHARACTERISTICS

Current-Gain — Bandwidth Product (I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 20 Vdc, f = 1.0 MHz)	f <sub>T</sub>	50	70	—	MHz
Output Capacitance (V <sub>CB</sub> = 20 Vdc, I <sub>E</sub> = 0, f = 1.0 MHz)	C <sub>obo</sub>	—	3.0	5.0	pF
Input Capacitance (V <sub>EB</sub> = 3.0 Vdc, I <sub>C</sub> = 0, f = 1.0 MHz)	C <sub>iob</sub>	—	60	75	pF

**MPQ7091**

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**CASE 646-05, STYLE 1**

**TO-116**

**QUAD AMPLIFIER TRANSISTOR**

**PNP SILICON**

Refer to MPQ7051 for graphs.